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## PHOTOTHERMOPLASTIC FILMS FOR HOLOGRAPHIC RECORDING

S. A. Neduzhiy, A. V. Pavlov, D. G. Tabatadze, T. V. Chel'tsova

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## PHOTOTHERMOPLASTIC FILMS FOR HOLOGRAPHIC RECORDING

S. A. Neduzhiy, A. V. Pavlov, D. G. Tabatadze, T. V. Chel'tsova

Among the photographic materials recently experiencing in- /149\* tensive development for recording information in holographic form, photothermoplastic (FTP) film consisting of a base, conducting layer and a layer consisting of a mixture of an organic photosemiconductor -- poly-N-vinyl carbozole -- and a thermoplastic material of a copolymer of styrene with divinyl (PVK-TP) is of great interest [1].

The PVK-TP composition does not have adequately high electrophotographic sensitivity (EFCh), so two methods are now used effectively to increase this system's EFCh: 1) introduction of assorted electron-acceptor impurities into the PVK-TP composition [2]; 2) a layer of amorphous selenium  $0.01\text{-}0.2~\mu\text{m}$  thick is applied between the conducting layer and the PVK-TP composition layer, which is from 1 to 6  $\mu\text{m}$  thick [3, 4]. The EFCh of the PVK-TP composition is increased when an additional layer of amorphous selenium is introduced because of injection of photogenerated charge carriers from the selenium layer into the PVK-TP composition layer under the influence of an electric field. Since PVK-TP has only p-type conduction, the conditions of the transport of vacancies from the layer of amorphous selenium through the PVK-TP layer are fulfilled for a negative surface charge.

It should be noted that FTP film based on Se-PVK-TP has a narrow spectral distribution of EFCh, corresponding to the spectral distribution of EFCh of amorphous selenium [5].

\*Numbers in the margin indicate pagination in the foreign text.

amorphous selenium was applied on a nickel-metalized Lavsan substrate by thermal evaporation at a substrate temperature of  $40^{\circ}\text{C}$  and a residual pressure in the chamber of about  $10^{-5}$  mmHg.

Impurities of Te, As, and Sb were added during the spraying /150 of the amorphous selenium to sensitize it. The total content of impurities in the selenium did not exceed 10%. Henceforth the layer of Se with Te, As, and Sb impurities shall be designated Se\*.

PVK-TP composition from a toluene solution was applied to the injected layers of Se and Se\* (in a 1:1 ratio). The EFCh of the photothermoplastic films was determined by the kinetics of the light decay of the potential using LG-31- ( $\lambda$  = 0.44  $\mu$ m) and LG-38-type ( $\lambda$  = 0.63  $\mu$ m) lasers. The sensitometric characteristics were determined using the procedure cited in [6].

Sensitization of Se using the above impurities leads to an increase in EFCh and expansion of the EFCh spectral range. The table shows the EFCh values according to criterion  $\Delta U/U_0=0.1$  ( $U_0$  is the initial charge potential) for films Se-PVK-TP and Se\*-PVK-TP, and, for comparison, for PVK-TP activated by trinitrofluorenone (TNF).

FTP film	EFCh, $m^2/J$ $\lambda = 0.63 \text{ µm}$ $\lambda = 0.44 \text{ µm}$	
PVK-TP-TNF	0.7	10
Se-PVK-TP	0.001	60
Se*-PVK-TP	8.0	400

Figure 1 shows the characteristic curves of the relationships of diffraction efficiency (DE)  $\eta$  and relative change of potential  $\Delta \textit{U}/\textit{U}_0$  to exposure H for  $\lambda$  = 0.63  $\mu m$  and  $\lambda$  = 0.44  $\mu m$ . The spatial

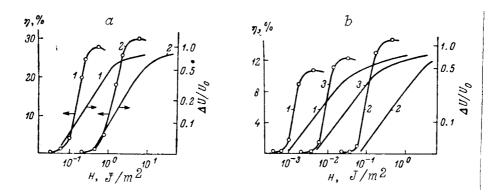


Fig. 1. Dependence of diffraction efficiency on relative change of potential  $\Delta U/U_0$  and exposure H for FTP films at  $\lambda$  = 0.63  $\mu$ m ( $\alpha$ ) and  $\lambda$  = 0.44  $\mu$ m (b).

1 -- Se (Te, As, Sb)-PVK-TP, 2 -- PVK-TP-TNF, 3 -- Se-PVK-TP.

frequency was 250 mm<sup>-1</sup> at a PVK-TP thickness  $\delta$  = 2  $\mu$ m.

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As we can see from Fig. 1 $\alpha$ , at  $\lambda$  = 0.63  $\mu$ m the dependence of DE for films Se\*-PVK-TP and PVK-TP-TNF (3%) is practically the same and the maximum value of DE is close to the maximum 33.9% [7]. At  $\lambda$  = 0.44  $\mu$ m (Fig. 1b) the value of DE is substantially lower than at  $\lambda$  = 0.64  $\mu$ m for all types of FTP films.

The reduction of maximum DE value may be associated with increase in light diffusion in the PVK-TP layer with decrease in  $\lambda$ , which leads to decrease in the degree of contrast of the interference bands.

As Fig. 1 shows, to generate deformation in this FTP film composition we need to change the potential on the order of 0.05 from the initial value  $U_0$  (in our case,  $U_0 = 400$  V), which is 20 V.

Figure 2 shows the dependence of  $\eta$  on spatial frequency f at  $\lambda$  = 0.63  $\mu$ m, which implies that introduction of an additional

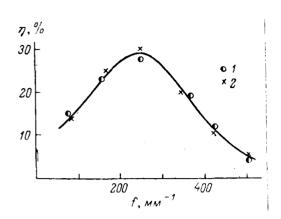


Fig. 2. Dependence of diffraction efficiency  $\eta$  on spatial frequency f at  $\lambda$  = 0.63  $\mu$ m. 1 -- Se\*-PVK-TP, 2 -- PVK-TP-TNF.

injection layer has practically no effect on the form of relationship  $f(\eta)$ . The optimal spatial frequency for FTP film 2  $\mu$ m thick is 250 mm<sup>-1</sup>, which corresponds to the theoretical ideas about thermoplastic deformed layers. The resonance spatial frequency is defined as  $f = 1/2\delta$ , where  $\delta$  is the thickness of the thermoplastic layer.

The above results imply that introduction of an injection layer of Se and Se\* allows increasing EFCh without marked reduction in DE value and virtually without change in resolution.

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